


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/710,421	SHEI ET AL.	
	Examiner	Art Unit	
	Joseph Nguyen	2815	

SEARCHED			
Class	Subclass	Date	Examiner
257	79, 99	4/3/2006	JN
257	90, 778	4/3/2006	JN
257	355	4/3/2006	JN
257	e33.052	4/3/2006	JN
257	e33.056	4/3/2006	JN

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
257	79, 99	4/3/06	JN
257	90, 778	4/3/06	JN
257	355	4/3/06	JN
257/E33.052 E33.056		4/3/06	JN

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Search history in EAST	4/3/2006	JN